



Integrated Device Technology, Inc.

3.3V CMOS 16-BIT BUS TRANSCEIVER/ REGISTERS

IDT54/74FCT163646/A/C

FEATURES:

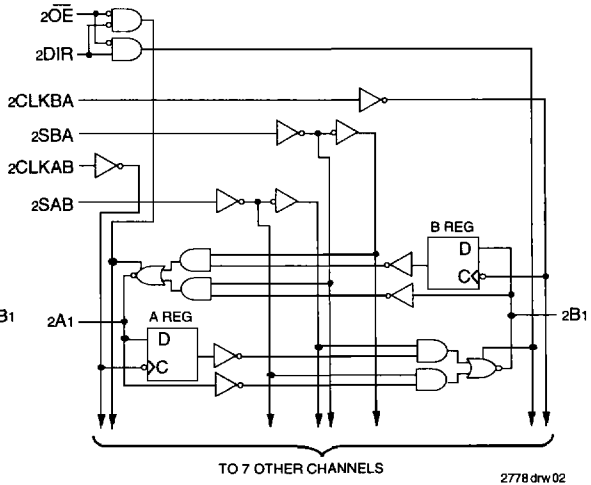
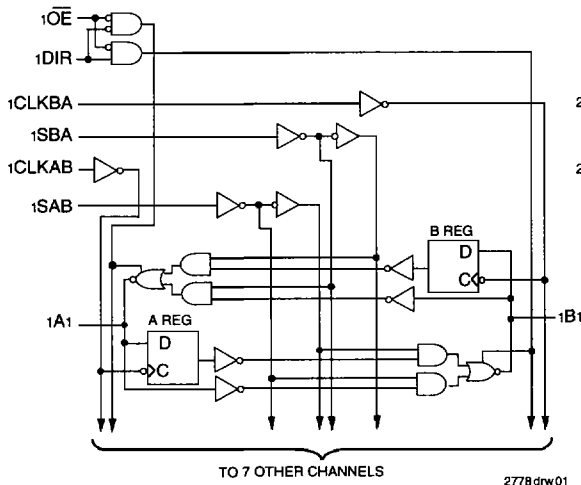
- 0.5 MICRON CMOS Technology
- **Typical tsk(o) (Output Skew) < 250ps**
- ESD > 2000V per MIL-STD-883, Method 3015;
- > 200V using machine model (C = 200pF, R = 0)
- 25 mil Center SSOP and Cerpack Packages and 19.6 mil pitch TSSOP Package
- Extended commercial range of -40°C to +85°C
- Vcc = 3.3V ±0.3V, Normal Range or Vcc = 2.7 to 3.6V, Extended Range
- CMOS power levels (0.4µW typ. static)
- Rail-to-Rail output swing for increased noise margin
- Military product compliant to MIL-STD-883, Class B
- Low Ground Bounce (0.3V typ.)
- Inputs (except I/O) can be driven by 3.3V or 5V components

DESCRIPTION:

The FCT163646/A/C 16-bit registered transceivers are built using advanced dual metal CMOS technology. These high-speed, low-power devices are organized as two independent 8-bit bus transceivers with 3-state D-type registers. The control circuitry is organized for multiplexed transmission of data between A bus and B bus either directly or from the internal storage registers. Each 8-bit transceiver/register features direction control (xDIR), over-riding Output Enable control (xOE) and Select lines (xSAB and xSBA) to select either real-time data or stored data. Separate clock inputs are provided for A and B port registers. Data on the A or B data bus, or both, can be stored in the internal registers by the LOW-to-HIGH transitions at the appropriate clock pins. Flow-through organization of signal pins simplifies layout. All inputs are designed with hysteresis for improved noise margin.

The FCT163646/A/C have series current limiting resistors. This offers low ground bounce, minimal undershoot, and controlled output fall times-reducing the need for external series terminating resistors.

FUNCTIONAL BLOCK DIAGRAM



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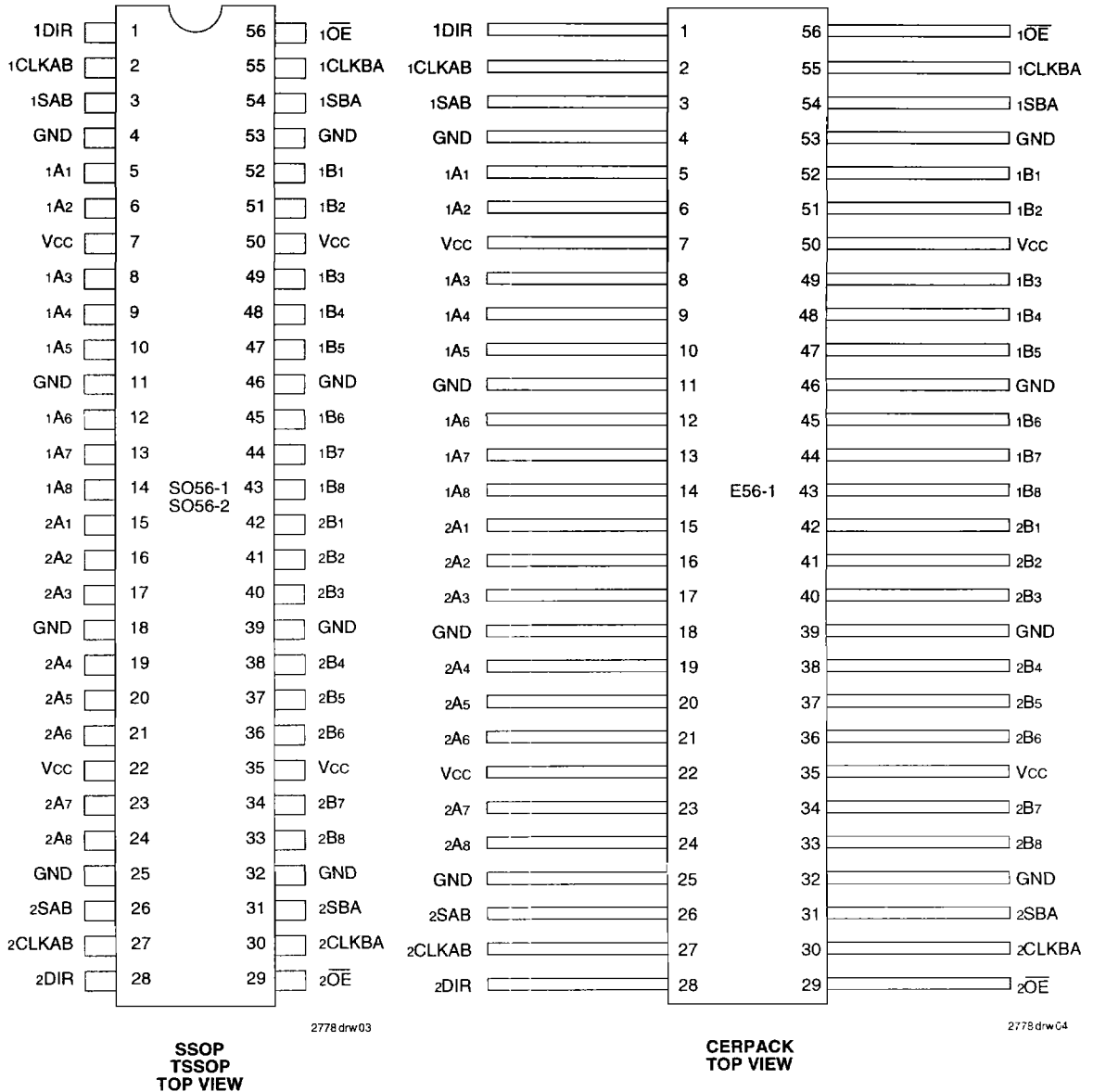
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MILITARY AND COMMERCIAL TEMPERATURE RANGES

JUNE 1996

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PIN CONFIGURATIONS



PIN DESCRIPTION

Pin Names	Description
xAx	Data Register A Inputs Data Register B Outputs
xBx	Data Register B Inputs Data Register A Outputs
xCAB, xCBA	Clock Pulse Inputs
xSAB, xSBA	Output Data Source Select Inputs
xDIR, xOE	Output Enable Inputs

2778 tbl 01

CAPACITANCE (TA = +25°C, f = 1.0MHz)

Symbol	Parameter(1)	Conditions	Typ.	Max.	Unit
CIN	Input Capacitance	VIN = 0V	3.5	6.0	pF
CIO	I/O Capacitance	VOUT = 0V	3.5	8.0	pF

NOTE: 2778 ink 04
1. This parameter is measured at characterization but not tested.

FUNCTION TABLE(2)

Inputs						Data I/O(1)		Operation or Function
xOE	xDIR	xCLKAB	xCLKBA	xSAB	xSBA	xAx	xBx	
H	X	H or L	H or L	X	X	Input	Input	Isolation Store A and B Data
H	X	↑	↑	X	X			
L	L	X	X	X	L	Output	Input	Real Time B Data to A Bus Stored B Data to A Bus
L	L	X	H or L	X	H			
L	H	X	X	L	X	Input	Output	Real Time A Data to B Bus Stored A Data to B Bus
L	H	H or L	X	H	X			

NOTES: 2778 tbl 02

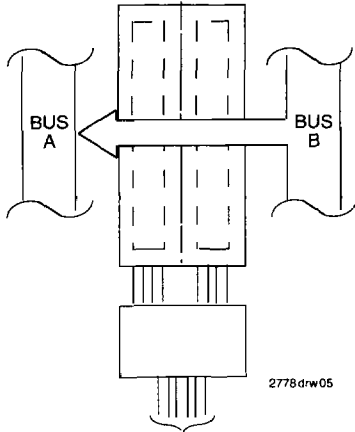
- The data output functions may be enabled or disabled by various signals at the xOE or xDIR inputs. Data input functions are always enabled, i.e. data at the bus pins will be stored on every LOW-to-HIGH transition on the clock inputs.
- H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care
↑ =LOW-to-HIGH Transition

ABSOLUTE MAXIMUM RATINGS(1)

Symbol	Rating	Commercial	Military	Unit
VTERM(2)	Terminal Voltage with Respect to GND	-0.5 to +4.6	-0.5 to +4.6	V
VTERM(3)	Terminal Voltage with Respect to GND	-0.5 to +7.0	-0.5 to +7.0	V
VTERM(4)	Terminal Voltage with Respect to GND	-0.5 to Vcc + 0.5	-0.5 to Vcc + 0.5	V
TA	Operating Temperature	-40 to +85	-55 to +125	°C
TBIAS	Temperature Under Bias	-55 to +125	-65 to +135	°C
TSTG	Storage Temperature	-55 to +125	-65 to +150	°C
PT	Power Dissipation	1.0	1.0	W
IOUT	DC Output Current	-60 to +60	-60 to +60	mA

- NOTES: 2778 ink 03
- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
 - Vcc terminals.
 - Input terminals.
 - Output and I/O terminals.

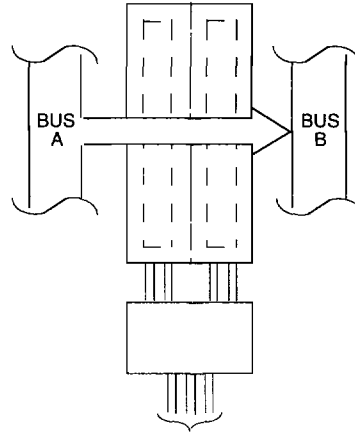




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xDIR	x $\overline{\text{OE}}$	xCLKAB	xCLKBA	xSAB	xSBA
L	L	X	X	X	L

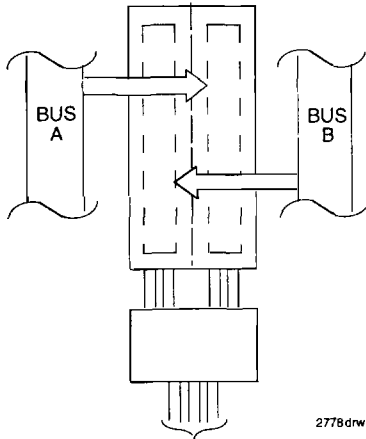
REAL-TIME TRANSFER
BUS B TO A



2778drw06

xDIR	x $\overline{\text{OE}}$	xCLKAB	xCLKBA	xSAB	xSBA
H	L	X	X	L	X

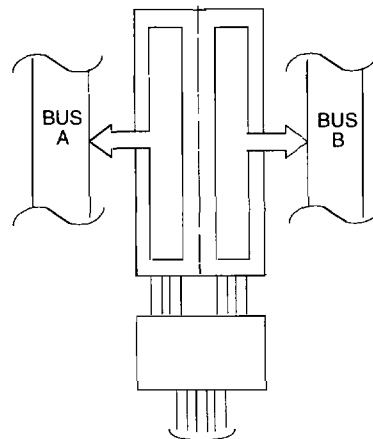
REAL-TIME TRANSFER
BUS A TO B



2778drw07

xDIR	x $\overline{\text{OE}}$	xCLKAB	xCLKBA	xSAB	xSBA
H	L	↑	X	X	X
L	L	X	↑	X	X
X	H	↑	↑	X	X

STORAGE FROM
A AND/OR B



2778 drw 08

xDIR ⁽¹⁾	x $\overline{\text{OE}}$	xCLKAB	xCLKBA	xSAB	xSBA
L	L	X	H or L	X	H
H	L	H or L	X	H	X

TRANSFER STORED
DATA TO A AND/OR B

NOTE:

1. Cannot transfer data to A bus and B bus simultaneously.

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Commercial: TA = -40°C to +85°C, VCC = 2.7V to 3.6V; Military: TA = -55°C to +125°C, VCC = 2.7V to 3.6V

Symbol	Parameter	Test Conditions ⁽¹⁾	Min.	Typ. ⁽²⁾	Max.	Unit	
VIH	Input HIGH Level (Input pins)	Guaranteed Logic HIGH Level	2.0	—	5.5	V	
	Input HIGH Level (I/O pins)		2.0	—	VCC+0.5		
VIL	Input LOW Level (Input and I/O pins)	Guaranteed Logic LOW Level	-0.5	—	0.8	V	
IIH	Input HIGH Current (Input pins) ⁽⁶⁾	VCC = Max. VI = 5.5V VI = VCC VI = GND VI = GND	—	—	±1	µA	
	Input HIGH Current (I/O pins) ⁽⁶⁾		—	—	±1		
IIL	Input LOW Current (Input pins) ⁽⁶⁾		—	—	±1		
	Input LOW Current (I/O pins) ⁽⁶⁾		—	—	±1		
IOZH	High Impedance Output Current (3-State Output pins) ⁽⁶⁾	VCC = Max. VO = VCC VO = GND	—	—	±1	µA	
IOZL			—	—	±1		
VIK	Clamp Diode Voltage	VCC = Min., IIN = -18mA	—	-0.7	-1.2	V	
IODH	Output HIGH Current	VCC = 3.3V, VIN = VIH or VIL, VO = 1.5V ⁽³⁾	-36	-60	-110	mA	
IODL	Output LOW Current	VCC = 3.3V, VIN = VIH or VIL, VO = 1.5V ⁽³⁾	50	90	200	mA	
VOH	Output HIGH Voltage	VCC = Min. VIN = VIH or VIL	IOH = -0.1mA IOH = -3mA	VCC-0.2 2.4	— 3.0	— —	V
		VCC = 3.0V VIN = VIH or VIL	IOH = -6mA MIL. IOH = -8mA COM'L.	2.4 ⁽⁵⁾	3.0	—	
		VCC = Min. VIN = VIH or VIL	IOH = 0.1mA IOH = 16mA IOH = 24mA	— — —	— 0.2 0.3	0.2 0.4 0.55	
VOL	Output LOW Voltage	VCC = 3.0V VIN = VIH or VIL	IOH = 24mA	—	0.3	0.50	V
		VCC = Min. VIN = VIH or VIL	IOH = 0.1mA IOH = 16mA IOH = 24mA	— — —	— 0.2 0.3	0.2 0.4 0.55	
		VCC = Min. VIN = VIH or VIL	IOH = 0.1mA IOH = 16mA IOH = 24mA	— — —	— 0.2 0.3	0.2 0.4 0.55	
IOS	Short Circuit Current ⁽⁴⁾	VCC = Max., VO = GND ⁽³⁾	-60	-135	-240	mA	
VH	Input Hysteresis	—	—	150	—	mV	
ICCL	Quiescent Power Supply Current	VCC = Max., VIN = GND or VCC	COM'L.	—	0.1	10	µA
ICCH			MIL.	—	0.1	100	
IC CZ			MIL.	—	0.1	100	

NOTES:

2778 hnk 05

- For conditions shown as Max. or Min., use appropriate value specified under Electrical Characteristics for the applicable device type.
- Typical values are at VCC = 3.3V, +25°C ambient.
- Not more than one output should be tested at one time. Duration of the test should not exceed one second.
- This parameter is guaranteed but not tested.
- VOH = VCC - 0.6V at rated current.
- The test limit for this parameter is ±5µA at TA = -55°C.



POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Conditions(1)		Min.	Typ.(2)	Max.	Unit
ΔI_{CC}	Quiescent Power Supply Current TTL Inputs HIGH	$V_{CC} = \text{Max.}$	$V_{IN} = V_{CC} - 0.6V^{(3)}$	—	2.0	30	μA
I_{CCD}	Dynamic Power Supply Current(4)	$V_{CC} = \text{Max.}$ Outputs Open $xDIR = x\overline{OE} = GND$ 50% Duty Cycle One Input Toggling	$V_{IN} = V_{CC}$ $V_{IN} = GND$	—	60	100	$\mu A / MHz$
I_C	Total Power Supply Current(6)	$V_{CC} = \text{Max.}$ Outputs Open $f_{CP} = 10MHz (xCLKBA)$ 50% Duty Cycle $xDIR = x\overline{OE} = GND$ $f_i = 5MHz$ 50% Duty Cycle One Bit Toggling	$V_{IN} = V_{CC}$ $V_{IN} = GND$	—	0.6	1.0	mA
			$V_{IN} = V_{CC} - 0.6V$ $V_{IN} = GND$	—	0.6	1.0	
		$V_{CC} = \text{Max.}$ Outputs Open $f_{CP} = 10MHz (xCLKBA)$ 50% Duty Cycle $xDIR = x\overline{OE} = GND$ $f_i = 2.5MHz$ 50% Duty Cycle Sixteen Bits Toggling	$V_{IN} = V_{CC}$ $V_{IN} = GND$	—	3.0	5.0(5)	
			$V_{IN} = V_{CC} - 0.6V$ $V_{IN} = GND$	—	3.0	5.3(5)	

2778 tbl 06

NOTES:

- For conditions shown as max. or min., use appropriate value specified under Electrical Characteristics for the applicable device type.
- Typical values are at $V_{CC} = 3.3V$, $+25^\circ C$ ambient.
- Per TTL driven input; all other inputs at V_{CC} or GND .
- This parameter is not directly testable, but is derived for use in Total Power Supply Calculations.
- Values for these conditions are examples of the I_{CC} formula. These limits are guaranteed but not tested.
- $I_C = I_{QUIESCENT} + I_{INPUTS} + I_{DYNAMIC}$
 $I_C = I_{CC} + \Delta I_{CC} DHNT + I_{CCD} (f_{CP}N_{CP}/2 + f_i N_i)$
 $I_{CC} = \text{Quiescent Current (} I_{CCL}, I_{CCH} \text{ and } I_{CCZ} \text{)}$
 $\Delta I_{CC} = \text{Power Supply Current for a TTL High Input}$
 $DH = \text{Duty Cycle for TTL Inputs High}$
 $N_T = \text{Number of TTL Inputs at } DH$
 $I_{CCD} = \text{Dynamic Current Caused by an Input Transition Pair (HLH or LHL)}$
 $f_{CP} = \text{Clock Frequency for Register Devices (Zero for Non-Register Devices)}$
 $N_{CP} = \text{Number of Clock Inputs at } f_{CP}$
 $f_i = \text{Input Frequency}$
 $N_i = \text{Number of Inputs at } f_i$

SWITCHING CHARACTERISTICS OVER OPERATING RANGE⁽⁴⁾

Symbol	Parameter	Condition ⁽¹⁾	FCT163646				FCT163646A				FCT163646C				Unit
			Com'l.		Mil.		Com'l.		Mil.		Com'l.		Mil.		
			Min. ⁽²⁾	Max.	Min. ⁽²⁾	Max.	Min. ⁽²⁾	Max.	Min. ⁽²⁾	Max.	Min. ⁽²⁾	Max.	Min. ⁽²⁾	Max.	
tPLH tPHL	Propagation Delay Bus to Bus	CL = 50pF RL = 500Ω	2.0	9.0	2.0	11.0	2.0	6.3	2.0	7.7	1.5	5.4	—	—	ns
tPZH tPZL	Output Enable Time xDIR or xOE to Bus		2.0	14.0	2.0	15.0	2.0	9.8	2.0	10.5	1.5	7.8	—	—	ns
tpHZ tPLZ	Output Disable Time xDIR or xOE to Bus		2.0	9.0	2.0	11.0	2.0	6.3	2.0	7.7	1.5	6.3	—	—	ns
tPLH tPHL	Propagation Delay Clock to Bus		2.0	9.0	2.0	10.0	2.0	6.3	2.0	7.0	1.5	5.7	—	—	ns
tPLH tPHL	Propagation Delay xSBA or xSAB to Bus		2.0	11.0	2.0	12.0	2.0	7.7	2.0	8.4	1.5	6.2	—	—	ns
tsu	Set-up Time HIGH or LOW Bus to Clock		4.0	—	4.5	—	2.0	—	2.0	—	2.0	—	—	—	ns
th	Hold Time HIGH or LOW Bus to Clock		2.0	—	2.0	—	1.5	—	1.5	—	1.5	—	—	—	ns
tw	Clock Pulse Width HIGH or LOW		6.0	—	6.0	—	5.0	—	5.0	—	5.0	—	—	—	ns
tsk(o)	Output Skew ⁽³⁾		—	0.5	—	0.5	—	0.5	—	0.5	—	0.5	—	—	ns

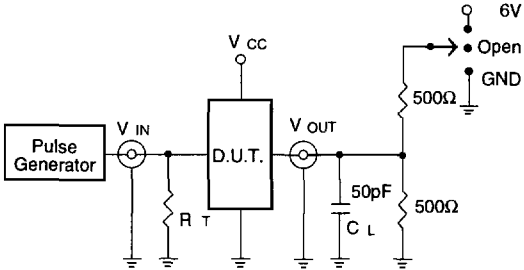
2778 tbl 07

NOTES:

1. See test circuit and waveforms.
2. Minimum limits are guaranteed but not tested on Propagation Delays.
3. Skew between any two outputs, of the same package, switching in the same direction. This parameter is guaranteed by design.
4. Propagation Delays and Enable/Disable times are with Vcc = 3.3V ±0.3V, Normal Range. For Vcc = 2.7V to 3.6V, Extended Range, all Propagation Delays and Enable/Disable times should be degraded by 20%.

TEST CIRCUITS AND WAVEFORMS

TEST CIRCUITS FOR ALL OUTPUTS



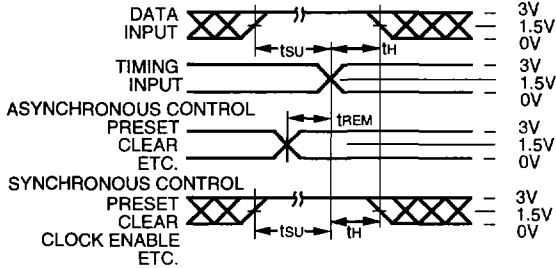
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SWITCH POSITION

Test	Switch
Open Drain Disable Low Enable Low	6V
Disable High Enable High	GND
All Other tests	Open

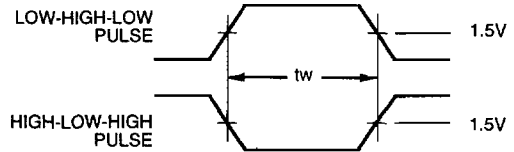
DEFINITIONS: 2778 Ink 08
 CL = Load capacitance: includes jig and probe capacitance.
 RT = Termination resistance: should be equal to Z_{out} of the Pulse Generator.

SET-UP, HOLD AND RELEASE TIMES



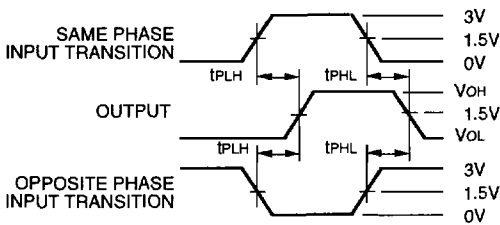
2778 drw 10

PULSE WIDTH



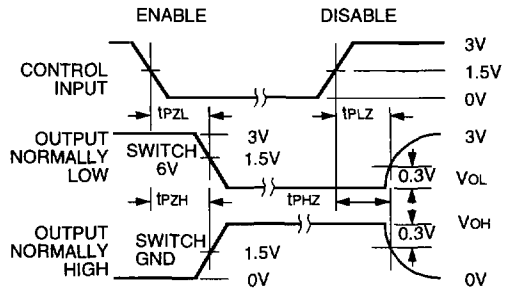
2778 drw 11

PROPAGATION DELAY



2778 drw 12

ENABLE AND DISABLE TIMES



2778 drw 13

NOTES:

1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.
2. Pulse Generator for All Pulses: Rate ≤ 1.0MHz; t_r ≤ 2.5ns; t_r ≤ 2.5ns.
3. If V_{cc} is below 3V, input voltage swings should be adjusted not to exceed V_{cc}.

ORDERING INFORMATION

IDT	XX	FCT	XXXX	X	X	
	Temp. Range		Device Type	Package	Process	
					Blank	Commercial
					B	MIL-STD-883, Class B
					PV	Shrink Small Outline Package (SO56-1)
					PA	Thin Shrink Small Outline Package (SO56-2)
					E	CERPACK (E56-1)
			163646			Non-Inverting 16-Bit Transceiver/ Register
			163646A			
			163646C			
					54	-55°C to +125°C
					74	-40°C to +85°C

2778drw14

